

<b>Notice of References Cited</b>	Application/Control No. 10/616,266	Applicant(s)/Patent Under Reexamination IKAWA ET AL.	
	Examiner Tawfik Goma	Art Unit 2627	Page 1 of 1

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*	C	US-2002/0071189	06-2002	Ohno, Takehide	359/813
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**NON-PATENT DOCUMENTS**

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